

1. Global joint venture starts operations as WeEn Semiconductors

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Thank you for your cooperation and understanding,

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Product data sheet

1. General description

Hyperfast power diode in a SOD113A (2-lead TO-220-F) plastic package.

2. Features and benefits

- Fast switching
- Isolated plastic package
- Low leakage current
- Low reverse recovery current
- Low thermal resistance
- Reduces switching losses in associated MOSFET or IGBT

3. Applications

- Active PFC in air conditioner
- High frequency switched-mode power supplies
- Continuous Current Mode (CCM) Power Factor Correction (PFC)

4. Quick reference data

| Table 1. Quick reference data | | | | | | | | |
|-------------------------------|---------------------------------|---|--|-----|-----|------|------|--|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit | |
| V _{RRM} | repetitive peak reverse voltage | | | - | - | 600 | V | |
| I _{F(AV)} | average forward current | δ = 0.5; square-wave pulse; <u>Fig. 1</u> ; Fig. 2 | | - | - | 20 | A | |
| Static characte | eristics | | | | | | | |
| V _F | forward voltage | I _F = 20 A; T _j = 150 °C; <u>Fig. 5</u> | | - | 1.2 | 1.97 | V | |
| Dynamic characteristics | | | | | | | | |
| t _{rr} | reverse recovery time | I_F = 1 A; V_R = 30 V; dI_F/dt = 200 A/µs; T _j = 25 °C; <u>Fig. 6</u> | | - | 16 | 20 | ns | |





5. Pinning information

| Table 2. | Pinning | information | | |
|----------|---------|-------------------------|--------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | К | cathode | mb | K A |
| 2 | А | anode | | 001aaa020 |
| mb | n.c. | mounting base; isolated | TO-220F (SOD113A) | |
| | | | TO-220F (SOD113A) | |

6. Ordering information

| Table 3. Ordering in | formation | | | | | |
|----------------------|-----------|---|---------|--|--|--|
| Type number | Package | | | | | |
| | Name | Description | Version | | | |
| BYC20DX-600P | TO-220F | plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 2-lead TO-220F "full pack" | SOD113A | | | |

7. Marking

| Table 4. Marking codes | |
|------------------------|--------------|
| Type number | Marking code |
| BYC20DX-600P | BYC20DX-600P |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

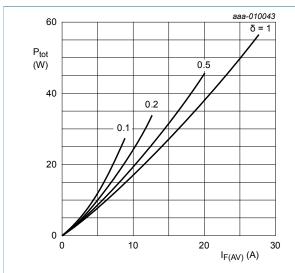
| Symbol | Parameter | Conditions | Min | Мах | Unit |
|--------------------|---------------------------------|---|-----|-----|------|
| V _{RRM} | repetitive peak reverse voltage | | - | 600 | V |
| V _{RWM} | crest working reverse voltage | | - | 600 | V |
| V _R | reverse voltage | DC | - | 600 | V |
| I _{F(AV)} | average forward current | δ = 0.5; square-wave pulse; Fig. 1; Fig. 2 | - | 20 | A |
| I _{FRM} | repetitive peak forward current | δ = 0.5; t _p = 25 µs; square-wave pulse | - | 40 | А |

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BYC20DX-600P

Hyperfast power diode

| Symbol | Parameter | Conditions | Min | Мах | Unit |
|------------------|-------------------------------------|--|-----|-----|------|
| I _{FSM} | non-repetitive peak forward current | t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 3 | - | 250 | A |
| | | t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 3 | - | 275 | А |
| T _{stg} | storage temperature | | -65 | 175 | °C |
| Tj | junction temperature | | - | 175 | °C |





$$I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$$

 $V_{\Omega} = 1.622 \text{ V}; \text{ R}_{\text{S}} = 0.016 \Omega$

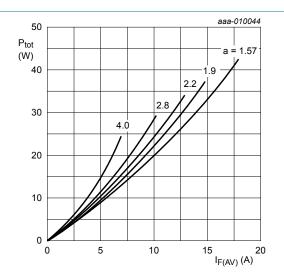
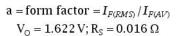
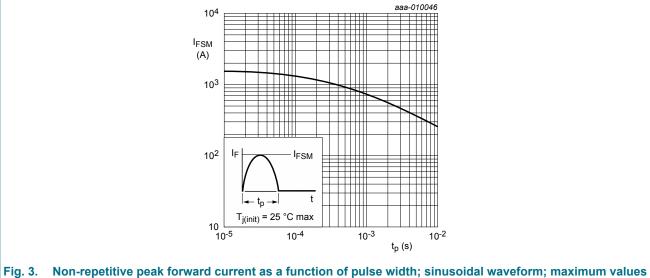


Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values

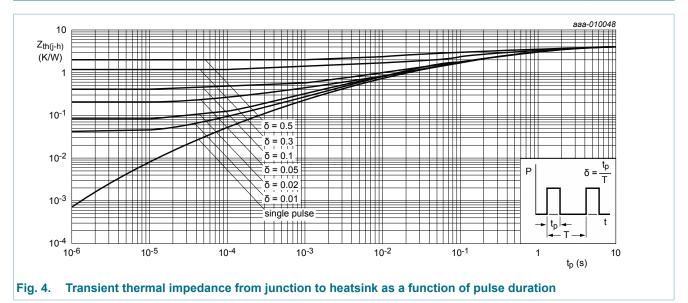




Hyperfast power diode

9. Thermal characteristics

| Table 6. T | hermal characteristics | | | | | |
|----------------------|--|--------------------------------|-----|-----|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| R _{th(j-h)} | thermal resistance from junction to heatsink | with heatsink compound; Fig. 4 | - | - | 4 | K/W |
| R _{th(j-a)} | thermal resistance from junction to ambient | in free air | - | 55 | - | K/W |



10. Isolation characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|-----------------------|---|-----|-----|------|------|
| V _{isol(RMS)} | RMS isolation voltage | 50 Hz \leq f \leq 60 Hz; RH \leq 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free | - | - | 2500 | V |
| C _{isol} | isolation capacitance | f = 1 MHz; from cathode to external heatsink | - | 10 | - | pF |

11. Characteristics

| Table 8. Characteristics | | | | | | | | |
|---|------------------------|--|--|-----|----------------|-----------------|-------------------|--|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit | |
| Static characte | Static characteristics | | | | | | | |
| V _F | forward voltage | I _F = 20 A; T _j = 25 °C; <u>Fig. 5</u> | | - | 2 | 2.9 | V | |
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BYC20DX-600P

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| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------|----------------------------------|---|-----|-----|------|------|
| | | I _F = 20 A; T _j = 150 °C; <u>Fig. 5</u> | - | 1.2 | 1.97 | V |
| I _R | reverse current | V _R = 600 V; T _j = 25 °C | - | - | 10 | μA |
| | | V _R = 600 V; T _j = 150 °C | - | - | 1 | mA |
| Dynamic c | haracteristics | · · · · · · | | | 1 | |
| Q _r | recovered charge | $I_F = 20 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ μ s; $T_j = 25 \text{ °C}; Fig. 6$ | - | 47 | - | nC |
| | | $I_F = 20 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ μ s; $T_j = 125 \text{ °C}; Fig. 6$ | - | 193 | - | nC |
| t _{rr} | reverse recovery time | $I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 200 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 6$ | - | 16 | 20 | ns |
| | | $I_F = 20 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/$ μ s; $T_j = 25 \text{ °C}; Fig. 6$ | - | 26 | - | ns |
| | | $I_F = 20 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ μ s; $T_j = 25 \text{ °C}; Fig. 6$ | - | 33 | - | ns |
| | | I_F = 20 A; V_R = 200 V; dI_F/dt = 200 A/ µs; T_j = 125 °C; <u>Fig. 6</u> | - | 51 | - | ns |
| I _{RM} | peak reverse recovery current | $I_F = 20 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/$ μ s; $T_j = 25 \text{ °C}; Fig. 6$ | - | 2.8 | - | A |
| | | I _F = 20 A; V _R = 200 V; dI _F /dt = 200 A/ μs; T _j = 125 °C; <u>Fig. 6</u> | - | 7.6 | - | A |

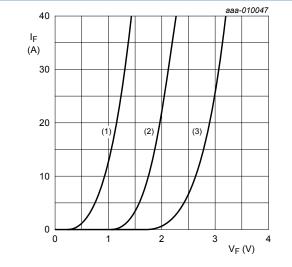
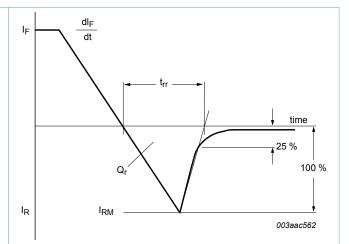


Fig. 5. Forward current as a function of forward voltage

(1) T_j = 150 °C; typical values;
 (2) T_j = 150 °C; maximum values;
 (3) T_j = 25 °C; maximum values;
 V_O = 1.622 V; R_S = 0.016 Ω







12. Package outline

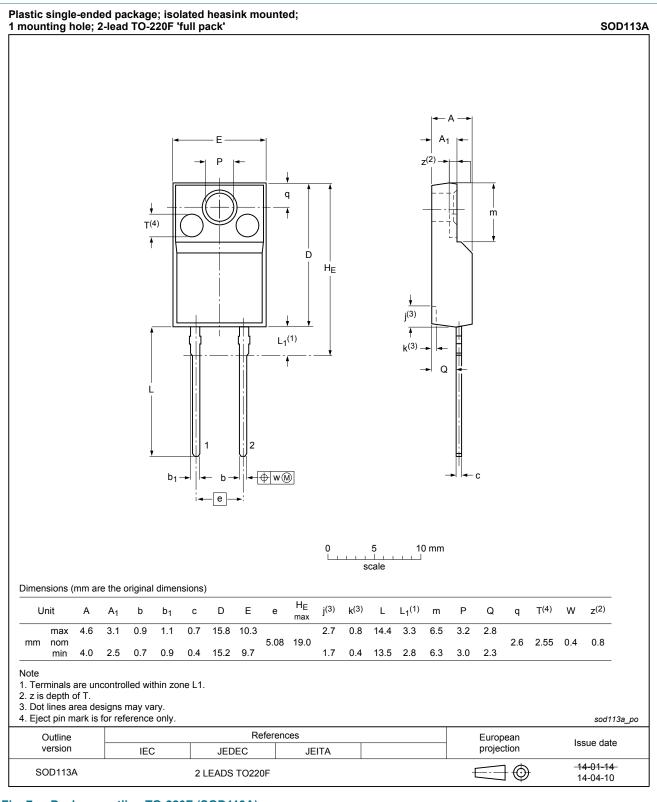


Fig. 7. Package outline TO-220F (SOD113A)

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|--------------------------------------|-------------------------------|---|
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14. Contents

| 1 | General description | 1 |
|------|---------------------------|---|
| 2 | Features and benefits | 1 |
| 3 | Applications | 1 |
| 4 | Quick reference data | 1 |
| 5 | Pinning information | 2 |
| 6 | Ordering information | 2 |
| 7 | Marking | 2 |
| 8 | Limiting values | 2 |
| 9 | Thermal characteristics | 4 |
| 10 | Isolation characteristics | 4 |
| 11 | Characteristics | 4 |
| 12 | Package outline | 6 |
| 13 | Legal information | 7 |
| 13.1 | Data sheet status | 7 |
| 13.2 | Definitions | 7 |
| 13.3 | Disclaimers | 7 |
| 13.4 | Trademarks | 8 |

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